

Page i

# RESISTORS, FIXED, WIREWOUND, POWER-TYPE, CHASSIS-MOUNTED, 10W, SEMI-PRECISION BASED ON TYPE RER65

# ESCC Detail Specification No. 4003/002

ISSUE 1 October 2002



Document Custodian: European Space Agency - see https://escies.org



## LEGAL DISCLAIMER AND COPYRIGHT

European Space Agency, Copyright © 2002. All rights reserved.

The European Space Agency disclaims any liability or responsibility, to any person or entity, with respect to any loss or damage caused, or alleged to be caused, directly or indirectly by the use and application of this ESCC publication.

This publication, without the prior permission of the European Space Ageny and provided that it is not used for a commercial purpose, may be:

- copied in whole in any medium without alteration or modification.
- copied in part, in any medium, provided that the ESCC document identification, comprising the ESCC symbol, document number and document issue, is removed.



# european space agency agence spatiale européenne

Pages 1 to 19

# **RESISTORS, FIXED, WIREWOUND, POWER-TYPE,**

# **CHASSIS-MOUNTED, 10W, SEMI-PRECISION**

# **BASED ON TYPE RER65**

# ESA/SCC Detail Specification No. 4003/002

# space components coordination group

		Appr	oved by
Issue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy
Issue 3	April 1994	Tomancers	Llat
Revision 'A'	January 1997	Sa (mitt-	Hoom



2

PAGE

## **DOCUMENTATION CHANGE NOTICE**

Rev. Letter	Rev. Date	CHANGE Reference Item	Approved DCR No.
'A'	Dec. '96	This Issue supersedes Issue 2A and incorporates all modifications agreed in DCR 221076 (rewriting of this specification).   P1. Cover page   P2. DCN   P15. Table 3 : Items 1 and 2, in Resistance Range column, "0.1" replaced with "1.0"   P18. Table 6 : Table updated   P19. Table 6 : Table updated	None None 23766 23766 23766



## TABLE OF CONTENTS

1.	GENERAL	Page 5
1.1	Scope	5
1.2	Type Variants and Range of Components	5
1.3	Maximum Ratings	5
1.4	Parameter Derating Information	5
1.5	Physical Dimensions	5
1.6	Functional Diagram	5
2.	APPLICABLE DOCUMENTS	10
3.	TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS	10
4.	REQUIREMENTS	10
4.1	General	10
4.2	Deviations from Generic Specification	10
4.2.1	Deviations from Special In-process Controls	10
4.2.2	Deviations from Final Production Tests	10
4.2.3	Deviations from Burn-in and Electrical Measurements	10
4.2.4	Deviations from Qualification Tests	10
4.2.5	Deviations from Lot Acceptance Tests	10
4.3 4.3.1	Mechanical Requirements Dimension Check	11 11
4.3.1	Weight	11
4.3.3	Robustness of Terminations	11
4.4	Materials and Finishes	11
4.4.1	Housing	11
4.4.2	Terminals	11
4.4.3	Wire	11
4.5	Marking	12
4.5.1	General	12
4.5.2	The SCC Component Number	12
4.5.3	Electrical Characteristics and Ratings	12
4.5.4	Traceability Information	13
4.6	Electrical Measurements	13
4.6.1	Electrical Measurements at Room Temperature	13
4.6.2	Electrical Measurements at High and Low Temperatures	13
4.6.3	Circuits for Electrical Measurements	13
4.7	Burn-in Tests	14
4.7.1	Parameter Drift Values	14
4.7.2	Conditions for Burn-in	14
4.7.3	Electrical Circuits for Burn-in	14
4.8	Environmental and Endurance Tests	17
4.8.1	Measurements and Inspections on Completion of Environmental Tests	17
4.8.2	Measurements and Inspections at Intermediate Points during Endurance Tests	17
4.8.3 4.8.4	Measurements and Inspections on Completion of Endurance Tests Conditions for Operating Life Tests	17 17
4.8.4 4.8.5	Electrical Circuits for Operating Life Tests	17
4.8.6	Conditions for High Temperature Storage Test	17
4.0.0		17

|--|

## **TABLES**

<u>Page</u>

N/A 16

1(a) 1(b)	Type Variants and Range of Components Maximum Ratings	6 6
2	Electrical Measurements at Room Temperature	15
3	Electrical Measurements at High and Low Temperatures	15
4 5(a)	Parameter Drift Values Conditions for Burn-in Test	16 16
5(b)	Conditions for Operating Life Test	16
6	Measurements and Inspections on Completion of Environmental Tests and at Intermediate Points and on Completion of Endurance Testing	18
FIGUE	RES	
1	Parameter Derating Information	7
2	Physical Dimensions	8
3	Functional Diagram	9

2	Physical Dimensions
3	Functional Diagram
4	Circuits for Electrical Measurements
5	Electrical Circuit for Burn-in and Operating Life Tests

# APPENDICES (Applicable to specific Manufacturers only)

None.



5

З

## 1. <u>GENERAL</u>

## 1.1 <u>SCOPE</u>

This specification details the ratings, physical and electrical characteristics, test and inspection data for Resistors, Fixed, Wirewound, Power-Type, Chassis-Mounted, 10W, Semi-Precision, based on Type RER65. It shall be read in conjunction with ESA/SCC Generic Specification No. 4003, the requirements of which are supplemented herein.

#### 1.2 TYPE VARIANTS AND RANGE OF COMPONENTS

Variants of the basic type resistors and the range of components covered by this specification are given in Figure 2 and Table 1(a) respectively.

#### 1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the resistors specified herein, are as scheduled in Table 1(b).

## 1.4 PARAMETER DERATING INFORMATION

The derating information applicable to the resistors specified herein is shown in Figure 1.

#### 1.5 PHYSICAL DIMENSIONS

The physical dimensions of the resistors specified herein are shown in Figure 2.

#### 1.6 FUNCTIONAL DIAGRAM

The functional diagram for the resistors specified herein is shown in Figure 3.



## TABLE 1(a) - TYPE VARIANTS AND RANGE OF COMPONENTS

Variant	Figure	Resistance Range (Note 1) Rn (Ω)	Tolerance (%)	Temperature Characteristic of Resistance (10 <sup>-6/°</sup> C)
01	2(a)	0.1 to 0.999 1.0 to 19.99	± 1.0-2.0-5.0-10 ± 0.5-1.0-2.0-5.0-10	100 (Note 2) 50 (Note 2)
02	2(b)	20 to 5620	± 0.5-1.0-2.0-5.0-10	30

## **NOTES**

1. The critical value is outside the resistance range.

2. For information only for values less than  $5.0\Omega$ .

		SYMBOL	LIMITS		UNIT	
NO.	CHARACTERISTIC	STMBUL	MIN.	MAX	UNIT	REMARKS
1	Rated Dissipation for Resistors Mounted on Chassis (1)	Pn	-	10	W	See Figure 1
2	Rated Dissipation for Unmounted Resistors	P <sub>n</sub>	-	6.0	W	See Figure 1
3	Limiting Element Voltage	UL	-	250	V	
4	Rated Voltage Mounted on Chassis (1)	U <sub>R</sub>	-	√10 R <sub>n</sub>	V	At T <sub>amb</sub> = +25°C
5	Overload Voltage and Time Mounted on Chassis (1)	U <sub>over I</sub> t	-	$\frac{\sqrt{R_n 50}}{5.0}$	Vac s	At T <sub>amb</sub> = +25°C
6	Operating Temperature Range	T <sub>amb</sub>	- 55	+ 200	°C	
7	Storage Temperature Range	T <sub>stg</sub>	- 55	+ 275	°C	
8	Maximum Soldering Temperature	T <sub>sol</sub>	-	+ 260	°C	Soldering time: t < 10s.

## TABLE 1(b) - MAXIMUM RATINGS

## **NOTES**

 The approximate dimensions of the chassis shall be:-Length: 153mm Width: 102mm Height: 51mm Thickness: 1.0mm

Approximate area: 400cm<sup>2</sup>.

See ESA/SCC Generic Specification No. 4003, Para. 9.1.1 for the mounting procedure.



## FIGURE 1 - PARAMETER DERATING INFORMATION



Rated Power versus Temperature

(For resistors mounted on chassis)



Rated Power versus Temperature

(For resistors not mounted on chassis)



# FIGURE 2(a) - PHYSICAL DIMENSIONS

Variant 01



SYMBOL	MILLIMETRES		
STIVIDUL	MIN.	MAX.	
А	33.36	36.50	
В	15.63	16.13	
С	1.60	3.18	
D	14.02	14.52	
E	17.48	20.62	
F	6.35	9.49	
G	9.56	12.70	
н	7.13	8.71	
J	19.83	21.41	
К	2.26	2.52	
L	9.52	11.10	
м	3.59	6.73	
N	1.60	3.18	
Р	2.03	2.29	
Q	1.95	2.15	
R	3.56	-	



## FIGURE 2 - PHYSICAL DIMENSIONS





SYMBOL	MILLIMETRES		
STINDUL	MIN.	MAX.	
А	-	-	
В	15.63	16.13	
С	1.60	3.18	
D	14.02	14.52	
Е	17.48	20.62	
G	9.56	12.70	
Н	7.13	8.71	
J	19.83	21.41	
К	2.26	2.52	
L	9.52	11.10	
М	3.59	6.73	
N	1.60	3.18	
Q	1.95	2.15	
S	0.75	0.85	
Т	36.00	40.00	
U	2.00	3.00	

## FIGURE 3 - FUNCTIONAL DIAGRAM





## 2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 4003, Resistors, Fixed, Wirewound, Power-type, Chassis-Mounted.
- (b) ESA/SCC Basic Specification No. 23500, Requirements for Lead Materials and Finishes for Components for Space Application.

## 3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

- IT Test current.
- R<sub>A</sub> Resistance value measured at ambient temperature (+22±3 °C).
- R<sub>i</sub> Insulation resistance.
- TCR Temperature characteristic of resistance.
- U<sub>T</sub> Test voltage.
- Uproof d.c. or r.m.s. voltage proof.

Uoverl - Overload voltage.

#### 4. **REQUIREMENTS**

#### 4.1 <u>GENERAL</u>

The complete requirements for procurement of the resistors specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 4003 for Resistors, Fixed, Wirewound. Deviations from the Generic Specification, applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirement and do not affect the components' reliability, are listed in the appendices attached to this specification.

#### 4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 Deviations from Special In-process Controls

None.

- 4.2.2 Deviations from Final Production Tests (Chart II) None.
- 4.2.3 <u>Deviations from Burn-in and Electrical Measurements (Chart III)</u> None.
- 4.2.4 <u>Deviations from Qualification Tests (Chart IV)</u>(a) Para. 9.18, Maximum Time Constant: Not applicable.
- 4.2.5 Deviations from Lot Acceptance Tests (Chart V)
  - (a) Para. 9.18, Maximum Time Constant: Not applicable.



## 4.3 MECHANICAL REQUIREMENTS

#### 4.3.1 Dimension Check

The dimensions of the resistors specified herein shall be specified in accordance with the requirements set out in Para. 9.3 of ESA/SCC Generic Specification No. 4003 and they shall conform to those shown in Figure 2 of this specification.

#### 4.3.2 Weight

The maximum weight of the resistors specified herein shall be 8.8 grams.

#### 4.3.3 Robustness of Terminations

The requirements for robustness of termination testing are specified in Para. 9.10 of ESA/SCC Generic Specification No. 4003. The test conditions shall be as follows:-

Variant 01

Test Condition : Ua

Applied Force : 20N

Variant 02

Test Condition : Ua, Ub or Uc

Applied Force for test condition Ua: 10N

#### 4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the resistors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

## 4.4.1 Housing

The housing shall be made from an aluminium alloy and shall be protected against corrosion. All fasteners shall be suitably plated.

#### 4.4.2 Terminals

Variant 01

The terminals shall be type 'C4' in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

#### Variant 02

The terminals shall be type 'B3' in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

## 4.4.3 <u>Wire</u>

Each resistor shall be wound with a conductor having no joints, welds or bonds within each terminated resistance element, except at the end terminals. In no case shall the nominal diameter be less than  $25\mu$ m. For wires with a nominal diameter of less than  $60\mu$ m, no abrasion with the view of acheiving the required resistance tolerance, is allowed. For diameters equal to or greater than that above, the abrasion, if performed, must be evenly distributed around the resistor body. The remaining cross-sectional area of the wire after the abrading operation shall be at least 90% of the original cross-sectional area.



## 4.5 MARKING

## 4.5.1 General

The marking of all components delivered to this specification shall be in accordance with ESA/SCC Basic Specification No. 21700 and the following paragraphs. Each component shall be marked in respect of:-

- (a) The SCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

#### 4.5.2 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:

	<u>400300201</u> 耳
Detail Specification Number	
Type Variant (See Table 1(a))	
Testing Level (B or C, as applicable)	

#### 4.5.3 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Numerical value.
- (b) Tolerance.
- (c) Temperature coefficient.

The information shall be constituted and marked as follows:-

	<u>2R55</u>	5 E 3	3
Resistance Value (2.55 ohms)			
Tolerance (±1%)		_	
Temperature Characteristic of Resistance (±50.10 <sup>-6/°</sup> C)			

4.5.3.1 Resistance Values

Resistance values shall be expressed by means of the following codes.

The unit quantity for marking shall be Ohms.

RESISTANCE VALUE	CODE
0.0XX	R0XX
0.XXX	RXXX
X.XX	XRXX
XX.X	XXRX
XXX	XXX0
XXX 101	XXX1

For values of 100 and above, the first three digits (X) represent significant figures and the last digit specifies the number of zeros to follow.

When values of less than 100 are required, the letter 'R' is used to indicate the decimal point. When the letter is used, all succeeding digits represent significant figures.



## 4.5.3.2 Tolerance

The tolerances on numerical values shall be indicated by the letter codes specified hereafter:-

TOLERANCE (%)	CODE LETTER
±0.5	D
± 1.0	F
±2.0	G
±5.0	J
± 10	К

## 4.5.3.3 Temperature Characteristic of Resistance

The temperature characteristic of resistance shall be indicated by the numerical codes specified hereafter:-

DIGIT	TEMPERATURE CHARACTERISTIC OF RESISTANCE ± 10 <sup>-6</sup> / °C		
9	30		
3	50		
4	100		

## 4.5.4 Traceability Information

Traceability information shall be marked in accordance with ESA/SCC Basic Specification No. 21700.

## 4.6 ELECTRICAL MEASUREMENTS

#### 4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. The measurements shall be performed at  $T_{amb}$  = +22 ± 3 °C.

#### 4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured on a sample basis at high and low temperatures are scheduled in Table 3. AQL shall be 0.65% (Level II) out of the total production lot. The distribution of the sample shall be as follows:-

- 1/3 with lowest resistance values.
- 1/3 with median resistance values.
- 1/3 with highest resistance values.

## 4.6.3 <u>Circuits for Electrical Measurements (Figure 4)</u>

Not applicable.



## 4.7 BURN-IN TESTS

#### 4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Measurements shall be performed at  $T_{amb} = +22\pm3$  °C. The parameter drift values ( $\Delta$ ) applicable to the parameter scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

#### 4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No.14003. The conditions for burn-in shall be as specified in Table 5(a). Resistors shall be tested with a d.c. voltage with a ripple not exceeding 5%. A voltage of  $\sqrt{6R_n}$  (see Figure 5), shall be applied in cycles of 90 minutes "on" and 30 minutes "off" throughout the test. The resistors shall be connected by their terminations to suitable clips on a rack of insulating material.

The resistors shall be so arranged that the temperature of any one resistor does not appreciably influence the temperature of any other resistor. There shall be no undue draught over the resistors. After the period specified in the Generic Specification, the resistors shall be removed from the chamber and allowed to cool under normal atmospheric conditions for a minimum of 4 hours.

#### 4.7.3 Electrical Circuits for Burn-in

The circuit for use in performing the burn-in tests is shown in Figure 5.



Rev. 'A'

## **TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE**

No.	Charactoristic	Characteristic Symbol Spec. and/or		Test	Test Tolerance		Limits							
NO.	No. Onaracteristic Oyin	Symbol	Test Method	Conditions	(%)	min	Max	Unit						
1	Resistance	R <sub>A</sub>	ESA/SCC	Para. 9.5.1.1	0.5	0.995 R <sub>n</sub>	1.005 R <sub>n</sub>	Ω						
		No. 4003				Generic Spec. No. 4003					1.0	0.99 R <sub>n</sub>	1.01 R <sub>n</sub>	
				2.0	0.98 R <sub>n</sub>	1.02 R <sub>n</sub>								
			5.0	0.95 R <sub>n</sub>	1.05 R <sub>n</sub>									
					10	0.90 R <sub>n</sub>	1.10 R <sub>n</sub>							
2	Insulation Resistance (Note 1)	R <sub>i</sub>	ESA/SCC Generic Spec. No. 4003	Para. 9.5.1.2	-	10 000	-	MΩ						
3	Voltage Proof (Note 1)	Vp	ESA/SCC Generic Spec. No. 4003	Para. 9.5.1.3	-	1 000	-	Vrms						

## **NOTES**

1. Measurements on a sample basis; sample size as specified in Para. 4.6.2.

## TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No	No. Characteristic	Characteristic Symbol Spec. and/or		Test	Resistance Range	Limits		Unit
NO.	Characteristic	Symbol	Test Method	Conditions	(Ω)	Min	Max	Unit
1	Resistance Change between	ΔR/R	ESA/SCC Para. 9.5.1.1 Generic Spec.		R <sub>n</sub> ≤1.0	-0.8	+ 0.8	%
	−55(+3−0) °C		No. 4003		1.0 <r<sub>n&lt;19.99</r<sub>	-0.4	+ 0.4	
	and +22±3 °C				R <sub>n</sub> >20	-0.25	+ 0.25	
2	Resistance Change between	ΔR/R	ESA/SCC Generic Spec.	Para. 9.5.1.1	R <sub>n</sub> ≤1.0	-1.5	+ 1.5	%
	+ 175( + 0-3) °C		No. 4003		1.0 <r<sub>n&lt;19.99</r<sub>	-0.75	+ 0.75	
	and +22±3 °C				R <sub>n</sub> >20	-0.45	+ 0.45	



## **TABLE 4 - PARAMETER DRIFT VALUES**

NO.	CHARACTERISTIC	SYMBOL	SPEC. AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS (Δ)	UNIT
1	Resistance Change	ΔR/R	As per Table 2	As per Table 2	±0.3 or (1)	%
					± 0.05	Ω

## **NOTES**

1. Whichever is the greater.

## FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

## TABLE 5(a) - CONDITIONS FOR BURN-IN TEST

NO.	CHARACTERISTIC	SYMBOL	CONDITION	UNIT
1	Temperature for Initial Measurement	T <sub>amb</sub>	+22±3	°C
2	Temperature for Burn-in Test	T <sub>amb</sub>	+ 25 ± 10	°C
3	Voltage applied, Unmounted Resistors	U <sub>T</sub> (1)	-√ 6 R <sub>n</sub>	Vdc or Vrms
4	Temperature for Final Measurement	T <sub>amb</sub>	+ 22 ± 3	°C

## <u>NOTES</u>

1. Or I<sub>T</sub> (See Figure 5).

TABLE 5(t	b) - CONDITIONS	FOR OPERATING	LIFE TEST

NO.	CHARACTERISTIC	SYMBOL	CONDITION	UNIT
1	Temperature for Initial Measurement	T <sub>amb</sub>	+ 22 ± 3	°C
2	Temperature for Operating Life Test	T <sub>amb</sub>	+ 25 ± 10	°C
3	Voltage applied, Mounted on Chassis	U <sub>T</sub> (1)	-√10 R <sub>n</sub>	Vdc or Vrms
4	Temperature for Final Measurement	T <sub>amb</sub>	+ 22 ± 3	°C

## **NOTES**

1. Or I<sub>T</sub> (See Figure 5).



## FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS



## NOTES



## 4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC</u> SPECIFICATION NO. 4003)

#### 4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. The measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

#### 4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. The measurements shall be performed at  $T_{amb} = +22 \pm 3 \text{ °C}$ .

#### 4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

#### 4.8.4 <u>Conditions for Operating Life Tests (Part of Endurance Testing)</u>

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 4003. The conditions for operating life testing shall be as specified in Table 5(b) of this specification.

4.8.5 <u>Electrical Circuits for Operating Life Tests</u>

The circuits for use in performing the operating life tests are shown in Figure 5.

#### 4.8.6 <u>Conditions for High Temperature Storage Test (Part of Endurance Testing)</u>

The requirements for the high temperature storage test are specified in Section 9 of ESA/SCC Generic Specification No. 4003. The temperature to be applied shall be the maximum storage temperature specified in Table 1(b) of this specification.



Rev. 'A'

## TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESA/SCC GENERIC	SPEC. No. 4003	MEASUREMENTS AN	ID INSPECTIONS		LIMITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
01	Overload	Para. 9.1 and Table 1(b) of this specification	Initial Measurements Resistance Final Measurements	Table 2 Item 1 After 1 to 2 hrs	R <sub>A</sub>	Table 2	Item 1	
			Visual Examination	recovery No damage Legible marking	-	-	-	-
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	±[0.3+((	0.05Ω/R)]	%
02	Permanence of Marking	Para. 9.6	Final Measurements Visual Examination	No corrosion or obliteration of marking	-	-	-	-
03	Temperature Characteristic of Resistance	Para. 9.7 Procedure II	During Test Temperature Characteristic of Resistance	Para. 9.7.3 of ESA/SCC No. 4003	TCR	Table	e 1(a)	10 <sup>−6/°</sup> C
04	Voltage Proof (Altitude)	Para. 9.8 500Vrms	Initial Measurements Resistance During Test	Table 2 Item 1 At Reduced Pressure	R <sub>A</sub>	Table 2	2 Item 1	
			Visual Examination	8mm Mercury No Breakdown or Flashover	-	-	-	-
			Final Measurements Resistance Change	Table 2 Item 1	$\Delta R_A / R_A$	±[0.2+(0	0. <b>05</b> Ω/R)]	%
05	Solderability	Para. 9.9 Procedure II	Final Measurements Visual Examination	No damage Legible marking	-	-	-	-
06	Robustness of Terminations	Para 9.10 and Para. 4.3.3 of this specification	Initial Measurements Resistance Final Measurements	Table 2 Item 1	R <sub>A</sub>	Table 2	Item 1	
			Visual Examination Resistance Change	No damage Table 2 Item 1	$\Delta R_A/R_A$	- ±[0.2+(	- 0.05Ω/R)]	- %
07	Resistance to Soldering Heat	Para. 9.11 Procedure I	Initial Measurements Resistance Final Measurements	Table 2 Item 1 After 24 ± 4 hours	R <sub>A</sub>	Table 2	2 Item 1	
			Visual Examination	recovery No damage Legible marking	-	-	-	-
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	±[0.3+(	0.05Ω/R)]	%
08	Rapid Change of Temperature	Para. 9.12 and Table 1(b) of this spec.	Initial Measurements Resistance Final Measurements	Table 2 Item 1 After 1 to 2 hrs recoverv	R <sub>A</sub>	Table 2	2 Item 1	
			Visual Examination Resistance Change	No damage Table 2 Item 1	$\Delta R_A/R_A$	- ±[0.5 + (	- 0.05Ω/R)]	- %
09	Vibration	Para. 9.13	Initial Measurements Resistance Final Measurements	Table 2 Item 1	R <sub>A</sub>	Table 2	2 Item 1	
			Visual Examination Resistance Change	No damage Table 2 Item 1	- ∆R <sub>A</sub> /R <sub>A</sub>	_ ±[0.2+((	- 0.05Ω/R)]	- %

## **NOTES**

1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.



Rev. 'A'

ISSUE 3

## TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

	ESA/SCC GENERIC	SPEC. NO. 4003	MEASUREMENTS AN	ID INSPECTIONS		LIM	IITS	
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
10	Climatic Sequence	Para. 9.14 Procedure I	Initial Measurements Resistance Final Measurements	After Drying Table 2 Item 1 After 1 to 2 hrs	R <sub>A</sub>	Table 2	Item 1	,
			Resistance Change Insulation Resistance	recovery Table 2 Item 1 Table 2 Item 2	$\frac{\Delta R_A / R_A}{R_i}$	±[1.0 + (0 1000	). <b>05</b> Ω/R)] -	% MΩ
11	Operating Life	Para. 9.15 Chart IV	Initial Measurements Resistance Intermediate Measurements	Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs	R <sub>A</sub>	Table 2	Item 1	
			Resistance Change Final Measurements	recovery Table 2 Item 1 2000 ± 48 hrs After 1 to 2 hrs recovery	∆R <sub>A</sub> /R <sub>A</sub>	±[0.8+(0	. <b>05</b> Ω/R)]	%
			Resistance Change	Table 2 Item 1	$\Delta R_A / R_A$	±[1.0+((	).05Ω/R)]	%
		Para. 9.15 Chart V	Initial Measurements Resistance Final Measurements	Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs	R <sub>A</sub>	Table 2	Item 1	
			Resistance Change	recovery Table 2 Item 1	$\Delta R_A / R_A$	±[0.8+(0	.05Ω/R)]	%
12	High Temperature Storage	Para. 9.16	Initial Measurements Resistance Intermediate Measurements	Table 2 Item 1 1000 ± 48 hrs	R <sub>A</sub>	Table 2	Item 1	
			Resistance Change Final Measurements Resistance Change	Table 2 Item 1 2000 ± 48 hrs Table 2 Item 1	$\Delta R_A/R_A$ $\Delta R_A/R_A$		0.05Ω/R)] 0.05Ω/R)]	% %
13	External Visual Inspection	Para. 9.17	Visual Inspection	ESA/SCC No. 20500	-	-	-	-
14	Maximum Time Constant (Not applicable to inductive resistors)	Para. 9.18 and Paras 4.2.4 and 4.2.5 of this spec.	Not applicable					

NOTES: See Page 18.